

1. Record Nr.	UNINA990008415940403321
Autore	Kalpazidou, Sophia L.
Titolo	Cycle representations of markov processes
Pubbl/distr/stampa	New York : Springer, c2006
ISBN	0-387-29166-0
Edizione	[2nd edit.]
Descrizione fisica	xx, 391 p. ; 24 cm
Collana	Stochastic modelling and applied probability ; 28
Disciplina	519.2
Locazione	MA1
Collocazione	C-39-(28-2ED
Lingua di pubblicazione	Inglese
Formato	Materiale a stampa
Livello bibliografico	Monografia

2. Record Nr.	UNICAMPANIASUN0108566
Titolo	Commentario breve alla riforma Jobs act / a cura di G. Zilio Grandi e M. Biasi
Pubbl/distr/stampa	[Assago] : Wolters Kluwer ; [Padova] : CEDAM, 2016
ISBN	978-88-13-35299-8
Descrizione fisica	XXVI, 818 p. ; 24 cm.
Lingua di pubblicazione	Italiano
Formato	Materiale a stampa
Livello bibliografico	Monografia
3. Record Nr.	UNINA9910688240003321
Titolo	Applied Aspects of Modern Metrology // edited by Oleh Velychko
Pubbl/distr/stampa	London : , : IntechOpen, , 2022 ©2022
Descrizione fisica	1 online resource (xi, 150 pages) : illustrations
Disciplina	389.1
Soggetti	Metrology
Lingua di pubblicazione	Inglese
Formato	Materiale a stampa
Livello bibliografico	Monografia
Note generali	Description based on publisher supplied metadata and other sources.
Nota di bibliografia	Includes bibliographical references.
Sommario/riassunto	In the modern era of scientific and technological development, the role of measurements and metrology in scientific research is becoming more and more important due to the increase in the testing of various products. Moreover, requirements for the accuracy and reliability of measurement results are increasing significantly and their ranges are expanding. Improving measurement accuracy allows us to identify the shortcomings of certain technological processes and either eliminate

them or reduce their influence. This leads to better-quality products and contributes to saving energy and other resources, as well as raw materials and materials. This book discusses relevant aspects of practical metrological activity to establish traceability of measurements while increasing their accuracy and reliability. It also presents procedures for the calibration and testing of measuring instruments.
